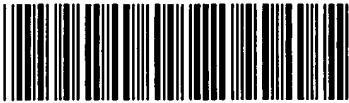


**Search Notes**

Application/Control No.

10/647,356

Examiner

Alex Liew

Applicant(s)/Patent under  
Reexamination

YAGI ET AL.

Art Unit

2624

**SEARCHED**

Class	Subclass	Date	Examiner
382	228	1/16/2007	AL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/224-227, 229-231 limited to text search	1/16/2007	AL
IEEE database text search	1/16/2007	AL
Consulted with Andy Johns on claim 13 USC 101 issue	1/17/2007	AL